

# **TEST REPORT**

Product Name : CM3566 Core Board

Model Number : CM3566-V2

Prepared for : BOARDCON TECHNOLOGY LIMITED

Address : ROOM702, XINAN BUSINESS BUILDING, 45ZONE,

**BAOAN DISTRCT** 

Prepared by : EMTEK (SHENZHEN) CO., LTD.

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Report Number : ENS2112140001E00101R

Date of Test : December 14, 2021 to December 20, 2021

Date of Report : December 20, 2021





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## TEST REPORT DESCRIPTION

Applicant : BOARDCON TECHNOLOGY LIMITED

Manufacturer : BOARDCON TECHNOLOGY LIMITED

Trade Mark : N/A

EUT : CM3566 Core Board

Model Number CM3566-V2

Power supply : AC 230V/50Hz, AC 120V/60Hz

#### **Measurement Procedure Used:**

EN 55032:2015+A11:2020, EN IEC 61000-3-2:2019,

EN 61000-3-3:2013+A1:2019,

EN 55035:2017+A11:2020

(IEC 61000-4-2:2008, IEC 61000-4-3:2006+A1:2007+A2:2010, IEC 61000-4-4:2012, IEC 61000-4-5:2014, IEC 61000-4-6:2013, IEC 61000-4-8:2009, IEC 61000-4-11:2004)

The device described above is tested by EMTEK (SHENZHEN) CO., LTD. to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and EMTEK (SHENZHEN) CO., LTD. is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the EN 55032, EN 61000-3-2, EN 61000-3-3, EN 55035 requirements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of EMTEK (SHENZHEN) CO., LTD.

Date of Test	:	December 14, 2021 to December 20, 2021
		Jungin Cai
Prepared by	:	SHENZHEN
		Junqin Cai/Editor
		Tre tra *
Reviewer	:	Joe Xia/Supervisor
Approved & Authorized Signer:		
		Lisa Wang/Manager



# **Modified Information**

Version	Report No.	Revision Date	Summary
Ver.1.0	ENS2112140001E00101R	/	Original Report





# 1. DESCRIPTION OF STANDARDS AND RESULTS (EUT)

		EMISSION			
Descr	ription of	Test Item	Standard	Limits	Results
Conducted Emissions Fr	rom the	AC Mains Power Ports		Class B	Pass
		network ports		Class B	N/A
Asymmetric mode	Optical	fibre ports		Class B	N/A
conducted emissions	Broadc	ast receiver tuner ports		Class B	N/A
	Antenn	a ports		Class B	N/A
	TV broa	adcast receiver tuner ports		Class B	N/A
Conducted differential	RF mod	dulator output ports	EN 55032	Class B	N/A
voltage emissions	FM bro	adcast receiver tuner ports		Class B	N/A
Radiated emissions at fr	equenci	es up to 1 GHz		Class B	Pass
Radiated emissions at fr		•		Class B	Pass
Radiated emissions from				Table A.6	N/A
Outdoor units of home s	atellite r	eceiving systems		Table A.7	N/A
Harmonic Current Emissions			EN 61000-3-2:2019	Class A	Pass
Voltage Fluctuation and	Flicker		EN61000-3-3:2013+A1: 2019	Section 5	Pass
		IMMUNITY			
Desci	ription o	f Test Item	Basic Standard	Performan ce Criteria	Results
Electrostatic Discharge		Enclosure ports	IEC 61000-4-2:2008	В	Pass
Continuous RF electrom field disturbances	agnetic	Enclosure ports	IEC 61000-4-3:2006+ A1:2007+A2:2010	Α	Pass
		AC mains power ports		В	Pass
Electrical fast transients/	burst/	Analogue/digital data ports	IEC61000-4-4:2012	В	N/A
		DC network power ports		N/A	N/A
		AC mains power ports		В	Pass
Surges		Analogue/digital data ports	IEC 61000-4-5:2014	С	N/A
5		DC network power ports		N/A	N/A
		AC mains power ports		Α	Pass
Continuous induced RF		Analogue/digital data ports	IEC 61000-4-6:2013	Α	N/A
disturbances		DC network power ports	1	N/A	N/A
Power frequency magne	tic field	· ·	IEC 61000-4-8:2009	Α	Pass
Power frequency magnetic field Voltage dips and interruptions		AC mains power ports	IEC 61000-4-11:2004	B, C	Pass



# 2. GENERAL INFORMATION

# 2.1. Description of Device (EUT)

EUT : CM3566 Core Board

Model Number : CM3566-V2

Applicant : BOARDCON TECHNOLOGY LIMITED

Address : ROOM702, XINAN BUSINESS BUILDING, 45ZONE, BAOAN DISTRCT

Manufacturer : BOARDCON TECHNOLOGY LIMITED

Address : ROOM702, XINAN BUSINESS BUILDING, 45ZONE, BAOAN DISTRCT

Date of Received : December 14, 2021

Date of Test : December 14, 2021 to December 20, 2021

# 2.2. Independent Operation Modes

A. On



## 2.3. Test Manner

Test Items	Test Voltage	Operation Modes	Worst case
Conducted disturbance at mains Terminals	AC 230V/50Hz AC 120V/60Hz	Mode A Mode A	Mode A (AC 120V/60Hz)
Radiated emissions at frequencies up to 1 GHz	AC 230V/50Hz AC 120V/60Hz	Mode A Mode A	Mode A (AC 120V/60Hz)
Radiated emissions at frequencies above 1 GHz	AC 230V/50Hz AC 120V/60Hz	Mode A Mode A	Mode A (AC 120V/60Hz)
Harmonic Current Emissions	AC 230V/50Hz	Mode A	\
Voltage Fluctuation and Flicker	AC 230V/50Hz	Mode A	\
Electrostatic Discharge	AC 230V/50Hz	Mode A	\
Continuous RF electromagnetic field disturbances	AC 230V/50Hz	Mode A	\
Electrical fast transients/burst	AC 230V/50Hz	Mode A	\
Surges	AC 230V/50Hz	Mode A	\
Continuous induced RF disturbances	AC 230V/50Hz	Mode A	\
Power frequency magnetic field	AC 230V/50Hz	Mode A	\
Voltage dips and interruptions	AC 230V/50Hz AC 120V/60Hz	Mode A	\

# 2.4. Description of Support Device

N/A



## 2.5. Description of Test Facility

Site Description

EMC Lab. : Accredited by CNAS, 2018.11.30

The certificate is valid until 2022.10.28

The Laboratory has been assessed and proved to be in compliance with

CNAS-CL01:2006 (identical to ISO/IEC 17025:2017) The Certificate Registration Number is L2291.

Accredited by FCC, August 09, 2018

Designation Number: CN1204

Test Firm Registration Number: 882943

Accredited by A2LA, August 08, 2018 The Certificate Number is 4321.01.

Accredited by Industry Canada, November 09, 2018 The Conformity Assessment Body Identifier is CN0008

Name of Firm

: EMTEK (SHENZHEN) CO., LTD.

Site Location

Building 69, Majialong, Industry Zone, Nanshan District, Shenzhen,

Guangdong, China 516025

## 2.6. Measurement Uncertainty

Test Item Uncertainty

Conducted Emission Uncertainty : 2.08dB (9k~150kHz Conduction 1#)

2.40dB (150k-30MHz Conduction 1#)

Radiated Emission Uncertainty

(3m 3# Chamber)

: 4.40dB (30M~1GHz Polarize: H) 5.04dB (30M~1GHz Polarize: V)

4.94dB (1~6GHz)

Uncertainty for Flicker test : 0.07%

Uncertainty for Harmonic test : 1.8%

Uncertainty for C/S Test : 1.45(Using CDN Test)

2.37(Using EM Clamp Test)

Uncertainty for R/S Test : 2.10dB(80MHz-200MHz)

1.76dB(200MHz-1000MHz)

Uncertainty for test site temperature : 0.6°C

and humidity

4%



# 3. MEASURING DEVICE AND TEST EQUIPMENT

## 3.1. For Conducted Emissions At the AC Mains Power Ports

Used	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
$\checkmark$	EMI Test Receiver	Rohde & Schwarz	ESCI	101384	May 15, 2021	1 Year
$\checkmark$	AMN	Rohde & Schwarz	ENV216	101161	May 15, 2021	1 Year
$\checkmark$	AMN	Kyoritsu	KNW-407	8-1492-9	May 16, 2021	1 Year

# 3.2. For Radiated Emission Measurement (3m)

Used	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
$\checkmark$	<b>EMI</b> Test Receiver	Rohde & Schwarz	ESU 26	100154	May 15, 2021	1 Year
<b>V</b>	Pre-Amplifie	Lunar EM	LNA10M1G-40	J10111309 12001	May 15, 2021	1 Year
$\checkmark$	Bilog Antenna	Schwarzbeck	VULB9163	659	June 12, 2021	2 Year
V	Horn antenna	Schwarzbeck	BBHA9120D	9120D-117 7	July 04, 2020	2 Year
<b>V</b>	Pre-Amplifie	SKET	LNPA_0118G-45	SK201905 1801	May 15, 2021	1 Year



## 3.3. For Harmonic Current / Flicker Measurement

Used	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
<b>V</b>	45KVA AC Power source	Teseq	NSG 1007-45/45KV A	1305A02873	May 16, 2021	1 Year
V	Signal conditioning Unit	Teseq	CCN 1000-3	1305A02873	May 16, 2021	1 Year
V	Impedance network	Teseq	INA2197/37A	1305A02873	May 16, 2021	1 Year
V	Impedance network	Teseq	INA 2196/75A	1305A02874	May 16, 2021	1 Year
	Profline 2100 AC Switching Unit	Teseq	NSG 2200-3	A22714	May 16, 2021	1 Year

# 3.4. For Electrostatic Discharge Immunity

Used	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
$\checkmark$	ESD Tester	TESEQ AG	NSG 438A	130	May 15, 2021	1 Year

# 3.5. For Continuous RF Electromagnetic Field Disturbances Immunity

Used	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
$\checkmark$	Power Amplifier	MILMEGA	AS0102-55	1018770	May 15, 2021	1 Year
	50ohm Diode Power Sensor	BOONTON	51011EMC	34236	May 16, 2021	1 Year
$\checkmark$	RF Power Meter. Dual Channel	BOONTON	4232A	10539	May 15, 2021	1 Year
$\checkmark$	LogPer. Antenna	SCHWARZBECK	VULP 9118E	811	N/A	N/A
$\checkmark$	Signal Generator	Agilent	N5181A	MY50145187	May 15, 2021	1 Year
	50ohm Diode Power Sensor	BOONTON	51011EMC	36164	May 15, 2021	1 Year
	Broad-Band Horn Antenna	SCHWARZBECK	STLP 9149	9149-227	N/A	N/A
	Field Strength Meter	DARE	RSS1006A	10I00037SNO 22	May 16, 2021	1 Year
	Multi-function interface system	DARE	CTR1009B	12I00250SNO 72	N/A	N/A
$\square$	Automatic switch group	DARE	RSW1004A	N/A	N/A	N/A
$\overline{\checkmark}$	Power Amplifier	MILMEGA	AS1860-50	1059346	May 15, 2021	1 Year
	Power Amplifier	MILMEGA	80RF1000-17 5	1059345	May 15, 2021	1 Year

# 3.6. For Electrical Fast Transient / Burst Immunity

Used	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
V	Burst Tester	HAEFELY	PEFT4010	080981-16	May 16, 2021	1 Year
V	Coupling Clamp	HAEFELY	IP-4A	147147	May 16, 2021	1 Year



# 3.7. For Surges Immunity

Used	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
$\checkmark$	Controller	HAEFELY	Psurge 8000	174031	May 16, 2021	1 Year
$\checkmark$	Impulse Module	HAEFELY	PIM 100	174124	May 16, 2021	1 Year
$\overline{\checkmark}$	Coupling Decoupling	HAEFELY	PCD 130	172181	May 16, 2021	1 Year
$\overline{\checkmark}$	Coupling Module	HAEFELY	PCD122	174354	May 16, 2021	1 Year
$\overline{\checkmark}$	Impulse Module	HAEFELY	PIM 120	174435	May 16, 2021	1 Year
$\checkmark$	Coupling Module	HAEFELY	PCD 126A	174387	May 16, 2021	1 Year
$\checkmark$	Impulse Module	HAEFELY	PIM 110	174391	May 16, 2021	1 Year
$\checkmark$	Impulse Module	HAEFELY	PIM 150	178707	May 16, 2021	1 Year

# 3.8. For Continuous Induced RF Disturbances Immunity

Used	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
$\overline{\checkmark}$	Continuous Wave Simulator	EMTEST	CWS500C	0900-12	May 15, 2021	1 Year
$\checkmark$	CDN	EMTEST	CDN-M2	51001001001 0	May 16, 2021	1 Year
	CDN	EMTEST	CDN-M3	0900-11	May 15, 2021	1 Year
	EM Injection Clamp	EMTEST	F-2031-23MM	368	May 15, 2021	1 Year
$\square$	Attenuator	EMTEST	100W 6dB DC-3G	/	May 15, 2021	1 Year
$\checkmark$	Power meter	AGILENT	E4418B	MY45102886	May 15, 2021	1 Year
$\checkmark$	Signal Generator	R&S	SMB100A	103041	May 15, 2021	1 Year

# 3.9. For Power Frequency Magnetic Field Immunity

Used	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
<b>V</b>	Magnetic Field Tester	HAEFELY	MAG100	250040.1	May 15, 2021	1 Year

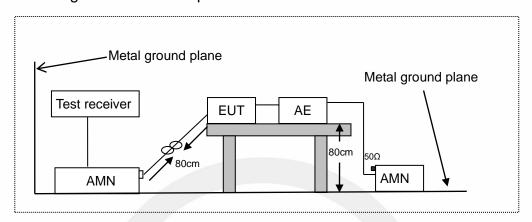
# 3.10. For Voltage Dips And Interruptions Immunity

Used	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
<b>V</b>	45KVA AC Power source	Teseq	NSG 1007-45/45KV A	1305A02873	May 16, 2021	1 Year
	Signal conditioning Unit	Teseq	CCN 1000-3	1305A02873	May 16, 2021	1 Year
	Impedance network	Teseq	INA2197/37A	1305A02873	May 16, 2021	1 Year
	Impedance network	Teseq	INA 2196/75A	1305A02874	May 16, 2021	1 Year
V	Profline 2100 AC Switching Unit	Teseq	NSG 2200-3	A22714	May 16, 2021	1 Year



#### 4. CONDUCTED EMISSIONS FROM THE AC MAINS POWER PORTS

# 4.1. Block Diagram of Test Setup



AMN: Artificial Mains Network AE: Associated equipment EUT: Equipment under test

#### 4.2. Limits

EN 55032, Class B, Table A.10

Frequency range MHz	Coupling device (see Table A.8)	Detector type / bandwidth	Class B limits dB(μV)
0.15 to 0.5			66 to 56
0.5 to 5	AMN	Quasi Peak / 9 kHz	56
5 to 30			60
0.15 to 0.5			56 to 46
0.5 to 5	AMN	Average / 9 kHz	46
5 to 30			50

#### 4.3. Test Procedure

The EUT was placed on a plank 0.8 m height from the metal ground plane and 0.4 m from the conducting wall of the shielding room and it was kept at least 0.8 m from any other grounded conducting surface. The size of the table will nominally be  $1.5 \text{ m} \times 1.0 \text{ m}$ .

The rear of the arrangement shall be flush with the back of the supporting tabletop unless that would not be possible or typical of normal use.

All units of equipment forming the system under test (includes the EUT as well as connected peripherals and associated equipment or devices) shall be arranged such that a nominal 0.1 m separation is achieved between the neighboring units.

Connect EUT to the power mains through a artificial mains network (AMN). Where the mains cable supplied by the manufacturer is longer than 1 m, the excess should be folded at the centre into a bundle



no longer than 0.4 m, so that its length is shortened to 1 m.

All the support units are connecting to the other AMN.

The AMN provides 50 ohm coupling impedance for the measuring instrument.

The CISPR states that the AMN with 50 ohm and 50 microhenry should be used.

Both sides of AC line were checked for maximum conducted interference.

The frequency range from 150 kHz to 30 MHz was sweep.

Set the test-receiver system to quasi peak detect function and average detect function, and to measure the conducted emissions values.

Test results were obtained from the following equation: Emission Level (dB $\mu$ V) = AMN Factor (dB) + Cable Loss (dB) + Reading (dB $\mu$ V) Margin (dB) = Emission Level (dB $\mu$ V) - Limit (dB $\mu$ V)

## 4.4. Measuring Results

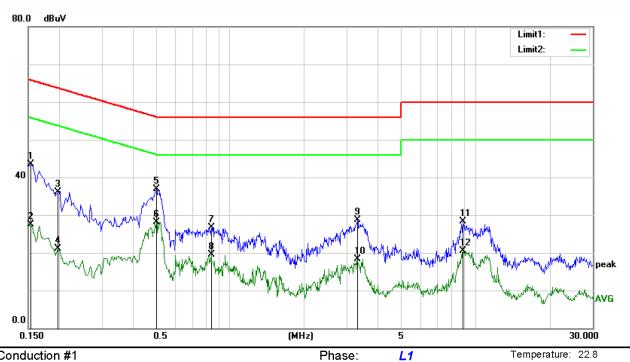
PASS.

Please see the attached page.



Humidity:

48 %



Power: AC 120V/60Hz

Site Conduction #1

Limit: (CE)EN55032 class B\_QP

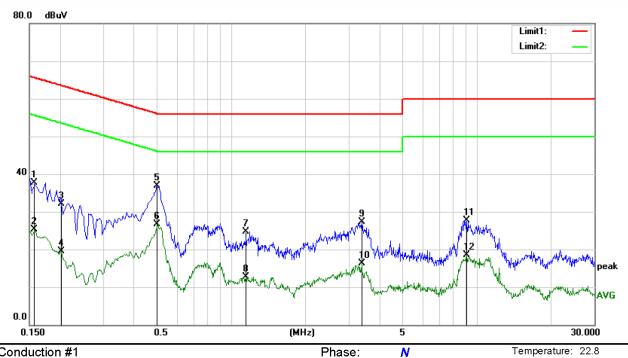
Mode: ON Note:

No. Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
	MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment
1	0.1540	34.08	9.44	43.52	65.78	-22.26	QP	
2	0.1540	18.07	9.44	27.51	55.78	-28.27	AVG	
3	0.1980	26.57	9.44	36.01	63.69	-27.68	QP	
4	0.1980	11.60	9.44	21.04	53.69	-32.65	AVG	
5	0.5020	27.67	9.27	36.94	56.00	-19.06	QP	
6 *	0.5020	18.88	9.27	28.15	46.00	-17.85	AVG	
7	0.8380	17.22	9.50	26.72	56.00	-29.28	QP	
8	0.8380	9.96	9.50	19.46	46.00	-26.54	AVG	
9	3.3020	18.94	9.82	28.76	56.00	-27.24	QP	
10	3.3020	8.39	9.82	18.21	46.00	-27.79	AVG	
11	8.8860	18.20	10.01	28.21	60.00	-31.79	QP	
12	8.8860	10.48	10.01	20.49	50.00	-29.51	AVG	



Humidity:

48 %



Power: AC 120V/60Hz

Site Conduction #1

Limit: (CE)EN55032 class B\_QP Mode: ON

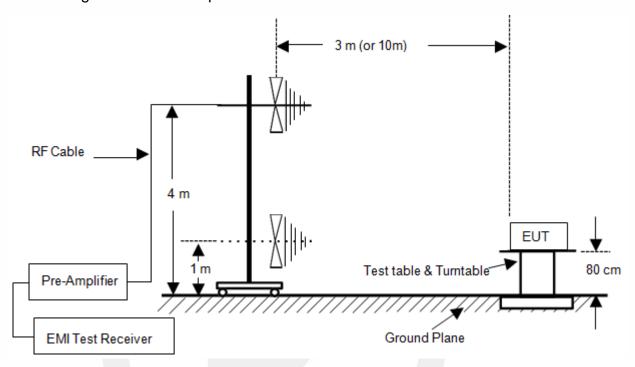
Note:

No. Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
	MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment
1	0.1580	28.17	9.44	37.61	65.57	-27.96	QP	
2	0.1580	15.79	9.44	25.23	55.57	-30.34	AVG	
3	0.2020	22.63	9.44	32.07	63.53	-31.46	QP	
4	0.2020	10.01	9.44	19.45	53.53	-34.08	AVG	
5 *	0.4980	27.72	9.27	36.99	56.03	-19.04	QP	
6	0.4980	17.45	9.27	26.72	46.03	-19.31	AVG	
7	1.1420	14.87	9.77	24.64	56.00	-31.36	QP	
8	1.1420	2.99	9.77	12.76	46.00	-33.24	AVG	
9	3.3860	17.42	9.82	27.24	56.00	-28.76	QP	
10	3.3860	6.44	9.82	16.26	46.00	-29.74	AVG	
11	9.0700	17.67	10.02	27.69	60.00	-32.31	QP	
12	9.0700	8.49	10.02	18.51	50.00	-31.49	AVG	



# 5. RADIATED EMISSION MEASUREMENT (UP TO 1GHz)

## 5.1. Block Diagram of Test Setup



#### 5.2. Radiated Limit

EN 55032, Class B, Table A.4

Frequency range		Measur	rement	Class A limits
MHz	Facility	Distance (m)	Detector type / bandwidth	dB(μV/m)
30 to 230	OATS/SAC	10		30
230 to 1 000	UATS/SAC	10	Quasi Peak / 120 kHz	37
30 to 230	OATS/SAC	3	Quasi Peak / 120 km2	40
230 to 1 000	UATS/SAC	3		47

#### 5.3. Test Procedure

The EUT was placed on a non-conductive table whose total height equaled 80cm. All units of equipment forming the system under test (includes the EUT as well as connected peripherals and associated equipment or devices) shall be arranged such that a nominal 0.1 m separation is achieved between the neighboring units. Where the mains cable supplied by the manufacturer is longer than 1 m, the excess should be folded at the centre into a bundle no longer than 0.4 m, so that its length is shortened to 1 m.

The EUT was set 3 meters (or 10 meters) away from the receiving antenna that was mounted on a non-conductive mast. The antenna can move up and down between 1 to 4 meters to find out the



maximum emission level.

The turntable can rotate 360 degree to determine the position of the maximum emission level.

The initial testing identified the frequency that has the highest disturbance relative to the limit while operating the EUT in typical modes of operation and cable positions in a test setup representative of typical system configuration.

The identification of the frequency of highest emission with respect to the limit was found by investigating emissions at a number of significant frequencies. The probable frequency of maximum emission had been found and that the associated cable and EUT configuration and mode of operation had been identified.

The bandwidth of the Receiver is set at 120 kHz.

Test results were obtained from the following equation: Emission level (dB $\mu$ V/m) = Antenna Factor -Amp Factor +Cable Loss + Reading Margin (dB) = Emission Level (dB $\mu$ V/m) - Limit (dB $\mu$ V/m)

## 5.4. Measuring Results

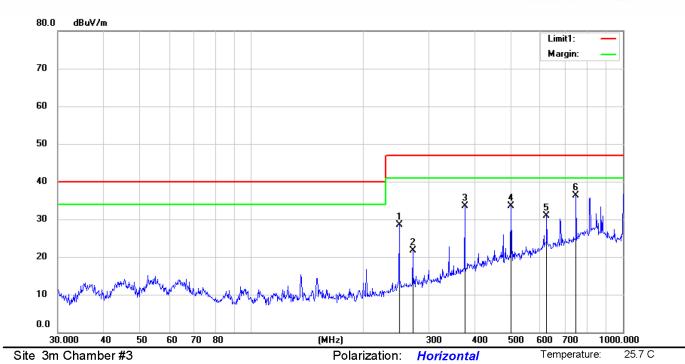
PASS.

Please see the attached page.



Humidity:

57 %



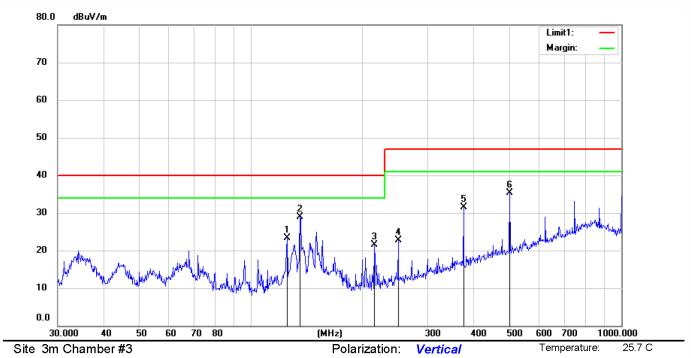
Limit: (RE)EN55032 class B

Mode:ON Note:

No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		Antenna Height	Table Degree	
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	cm	degree	Comment
1		250.0820	43.29	-14.79	28.50	47.00	-18.50	QP			
2		272.0391	35.61	-13.92	21.69	47.00	-25.31	QP			
3		375.1155	43.90	-10.31	33.59	47.00	-13.41	QP			
4		500.0818	40.65	-7.20	33.45	47.00	-13.55	QP			
5		625.0780	35.52	-4.60	30.92	47.00	-16.08	QP			
6	*	750.1083	37.87	-1.56	36.31	47.00	-10.69	QP			

Power: AC 120V/60Hz





Limit: (RE)EN55032 class B

Mode:ON Note:

No.	Mk	c. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		Antenna Height	Table Degree	
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	cm	degree	Comment
1		125.0066	40.80	-17.55	23.25	40.00	-16.75	QP			
2	*	135.9822	46.42	-17.49	28.93	40.00	-11.07	QP			
3		215.9293	38.18	-16.73	21.45	40.00	-18.55	QP			
4		250.0820	37.54	-14.79	22.75	47.00	-24.25	QP			
5		375.1155	41.88	-10.31	31.57	47.00	-15.43	QP			
6		500.0818	42.48	-7.20	35.28	47.00	-11.72	QP			

Power: AC 120V/60Hz

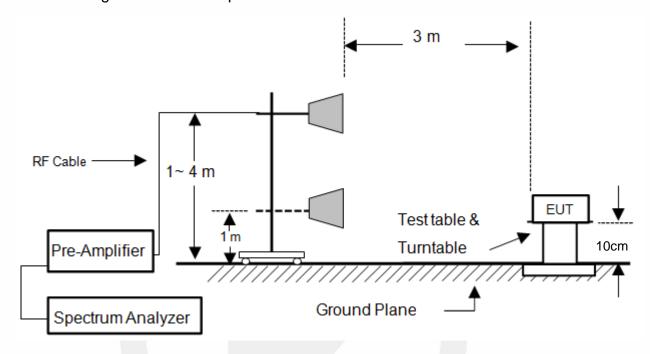
57 %

Humidity:



# 6. RADIATED EMISSION MEASUREMENT (ABOVE 1GHz)

### 6.1. Block Diagram of Test Setup



## 6.2. Radiated Limit

EN 55032, Class B, Table A.50

Frequency range		Measur	rement	Class A limits
(MHz)	Facility	Distance (m)	Detector type/ bandwidth	dB(μV/m)
1000 to 3000				50
3000 to 6000	=00.1=0		Average / 1 MHz	54
1000 to 3000	FSOATS	3		70
3000 to 6000			Peak /1 MHz	74

Note: The highest internal source of an EUT is defined as the highest frequency generated or used within the EUT or on which the EUT operates or tunes. If the highest frequency of the internal sources of the EUT is less than 108 MHz, the measurement shall only be made up to 1 GHz. If the highest frequency of the internal sources of the EUT is between 108 MHz and 500 MHz the measurement shall only be made up to 2 GHz. If the highest frequency of the internal sources of the EUT is between 500 MHz and 1 GHz, the measurement shall only be made up to 5 GHz. If the highest frequency of the internal sources of the EUT is above 1 GHz, the measurement shall be made up to 5 times the highest frequency or 6 GHz, whichever is less.



#### 6.3. Test Procedure

The EUT was placed on a non-conductive table whose total height equaled 80cm. All units of equipment forming the system under test (includes the EUT as well as connected peripherals and associated equipment or devices) shall be arranged such that a nominal 0.1 m separation is achieved between the neighboring units. Where the mains cable supplied by the manufacturer is longer than 1 m, the excess should be folded at the centre into a bundle no longer than 0.4 m, so that its length is shortened to 1 m.

The EUT was set 3 meters away from the receiving antenna that was mounted on a non-conductive mast. The antenna can move up and down between 1 to 4 meters to find out the maximum emission level.

The turntable can rotate 360 degree to determine the position of the maximum emission level.

The initial testing identified the frequency that has the highest disturbance relative to the limit while operating the EUT in typical modes of operation and cable positions in a test setup representative of typical system configuration.

The identification of the frequency of highest emission with respect to the limit was found by investigating emissions at a number of significant frequencies. The probable frequency of maximum emission had been found and that the associated cable and EUT configuration and mode of operation had been identified.

The frequency range above 1GHz the measuring instrument use RBW=1 MHz and VBW=3 MHz.

Test results were obtained from the following equation: Emission level (dB $\mu$ V/m) = Antenna Factor - Amp Factor + Cable Loss + Reading Margin (dB) = Emission Level (dB $\mu$ V/m) - Limit (dB $\mu$ V/m)

#### 6.4. Measuring Results

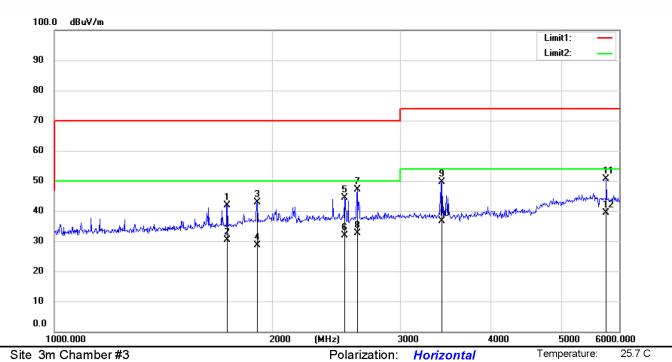
#### **PASS**

All the modes were tested and the data of the worst modes are attached the following pages.



Humidity:

57 %



Power: AC 120V/60Hz

Limit: (RE)EN55032 class B

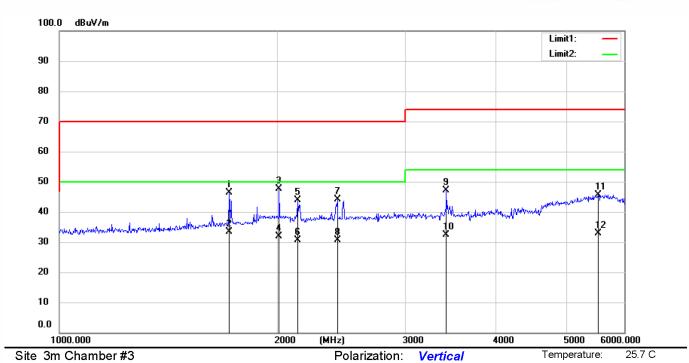
Mode:ON Note:

No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		Antenna Height	Table Degree	
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	cm	degree	Comment
1		1730.659	56.50	-14.60	41.90	70.00	-28.10	peak			
2		1730.659	45.10	-14.60	30.50	50.00	-19.50	AVG			
3		1903.917	56.36	-13.57	42.79	70.00	-27.21	peak			
4		1903.917	42.17	-13.57	28.60	50.00	-21.40	AVG			
5		2516.216	57.22	-12.92	44.30	70.00	-25.70	peak			
6		2516.216	44.82	-12.92	31.90	50.00	-18.10	AVG			
7		2613.282	59.85	-12.80	47.05	70.00	-22.95	peak			
8		2613.282	45.40	-12.80	32.60	50.00	-17.40	AVG			
9	;	3422.142	61.83	-12.16	49.67	74.00	-24.33	peak			
10	;	3422.142	48.86	-12.16	36.70	54.00	-17.30	AVG			
11	;	5764.214	55.43	-4.90	50.53	74.00	-23.47	peak			
12	*	5764.214	44.40	-4.90	39.50	54.00	-14.50	AVG			



Humidity:

57 %



Power: AC 120V/60Hz

Limit: (RE)EN55032 class B

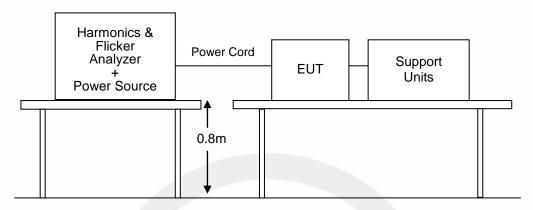
Mode:ON Note:

No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		Antenna Height	Table Degree	
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	cm	degree	Comment
1		1715.608	60.99	-14.67	46.32	70.00	-23.68	peak			
2	*	1715.608	48.07	-14.67	33.40	50.00	-16.60	AVG			
3		2011.310	60.46	-12.95	47.51	70.00	-22.49	peak			
4		2011.310	44.85	-12.95	31.90	50.00	-18.10	AVG			
5		2132.388	56.95	-12.95	44.00	70.00	-26.00	peak			
6		2132.388	43.65	-12.95	30.70	50.00	-19.30	AVG			
7		2415.711	57.03	-12.94	44.09	70.00	-25.91	peak			
8		2415.711	43.64	-12.94	30.70	50.00	-19.30	AVG			
9		3415.251	59.21	-12.16	47.05	74.00	-26.95	peak			
10		3415.251	44.56	-12.16	32.40	54.00	-21.60	AVG			
11		5531.496	50.59	-4.92	45.67	74.00	-28.33	peak			
12		5531.496	37.82	-4.92	32.90	54.00	-21.10	AVG			



# 7. HARMONIC CURRENT EMISSION MEASUREMENT

# 7.1. Block Diagram of Test Setup



#### 7.2. Standard Limits

#### EN 61000-3-2, CLASS A

Harmonic current emissions evaluate the potential for the EUT to cause distortion on the AC power lines. It is applicable to electrical and electronic equipment having an input current≤16 A per phase, and intended to be connected to public low-voltage distribution systems

Table 1 - Limits for Class A equipment

Harmonic order		Maximum permissible harmonic current (A)
	Odd har	monics
3	1	2.30
5		1.14
7		0.77
9		0.40
11		0.33
13		0.21
15 ≤ n ≤ 39		0.15
	Even ha	rmonics
2		1.08
4		0.43
6		0.30
8 ≤ n ≤ 40		0.23 <u>8</u>



#### 7.3. Test Procedure

The measurement of harmonic currents shall be performed as follows: i. For each harmonic order, measure the 1.5 s smoothed r.m.s. harmonic current in each DFT time window as defined in EN / IEC 61000-4-7:2009. ii. Calculate the arithmetic average of the measured values from the DFT time windows, over the entire observation period Short cyclic (T cycle≤2.5 min). Because of synchronisation to meet the requirements for repeatability in 5%.

### 7.4. Test Results

N/A.

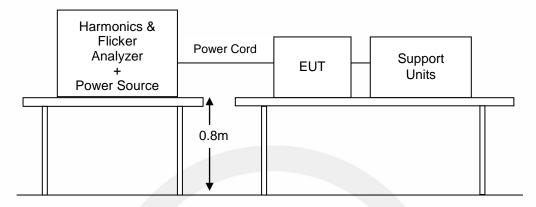
Because power of EUT less than 75W, According standard EN 61000-3-2, Harmonic current unnecessary to test.





#### 8. VOLTAGE FLUCTUATION AND FLICKER MEASUREMENT

## 8.1. Block Diagram of Test Setup



#### 8.2. Standard Limits

#### EN 61000-3-3 Limits

The objective of voltage changes, voltage fluctuations and flicker in public low voltage supply systems during equipment with rated current≤16 A per phase, ensures that home appliances and certain other electrical equipment do not adversely affect lighting equipment when connected to the same power system.

Voltage Fluctuation and Flicker Limits:

- the value of Pst shall not be greater than 1.0;
- the value of Plt shall not be greater than 0.65;
- the value of d(t) during a voltage change shall not exceed 3.3 % for more than 500 ms;
- the relative steady-state voltage change, dc, shall not exceed 3.3 %;
- the maximum relative voltage change, dmax, shall not exceed 4.0 %;

#### 8.3. Test Procedure

The total impedance of the test circuit, excluding the appliance under test, but including the internal impedance of the supply source, shall be equal to the reference impedance. The stability and tolerance of the reference impedance shall be adequate to ensure that the overall accuracy of 8% is achieved during the whole assessment procedure.

#### 8.4. Test Results

#### **PASS**

All the modes were tested and the data of the worst modes are attached the following pages.



# Flicker Test Summary per EN/IEC61000-3-3 Ed. 3.0 (2013) (Run time)

EUT: CM3566-V2 Tested by: LHT
Test category: All parameters (European limits) Test Margin: 100
Test date: 2021/12/15 Start time: 23:44:55 End time: 23:55:22
Test duration (min): 10 Data file name: WIN2105\_F-000031.cts\_data

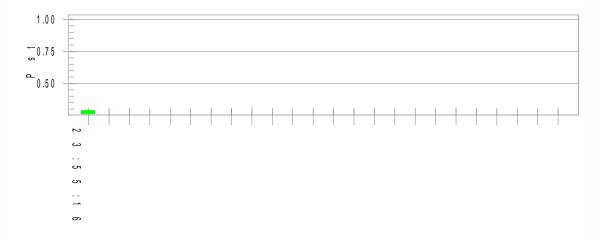
Comment: ON

**Customer: BOARDCON TECHNOLOGY LIMITED** 

Test Result: Pass Status: Test Completed

#### Psti and limit line

#### **European Limits**



Parameter values recorded during the test:

Vrms at the end of test (Volt): 230.82 500.0 T-max (mS): 0.0 Test limit (mS): **Pass** Test limit (%): Test limit (%): Highest dc (%): 0.00 3.30 **Pass** Highest dmax (%): Highest Pst (10 min. period): 0.04 4.00 **Pass** 0.288 Test limit: 1.000 **Pass** Highest Plt (2 hr. period): 0.126 **Test limit:** 0.650 **Pass** 



#### 9. IMMUNITY GENERAL PERFORMANCE CRITERIA DESCRIPTION

General performance criteria are defined in EN 55035 clause 8.2, 8.3 and 8.4. These criteria shall be used during the testing of primary functions where no relevant annex is applicable.

When assessing the impact of a disturbance on a function, the assessment should take into consideration the function's performance prior to the application of the disturbance and only identify as failures those changes in performance that are a result of the disturbance.

#### EN 55035:

#### Performance criterion A

The equipment shall continue to operate as intended without operator intervention. No degradation of performance, loss of function or change of operating state is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

#### Performance criterion B

During the application of the disturbance, degradation of performance is allowed. However, no unintended change of actual operating state or stored data is allowed to persist after the test.

After the test, the equipment shall continue to operate as intended without operator intervention; no degradation of performance or loss of function is allowed, below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance.

If the minimum performance level (or the permissible performance loss), or recovery time, is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

#### Performance criterion C

Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. A reboot or re-start operation is allowed. Information stored in non-volatile memory, or protected by a battery backup, shall not be lost.



#### 10. ELECTROSTATIC DISCHARGE

### 10.1.Test Specification

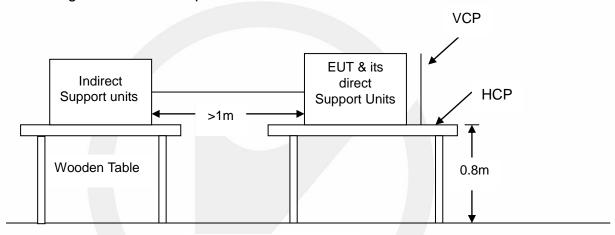
Test standard : EN 55035
Basic standard : IEC 61000-4-2

Performance criterion : B

Test level : ±8.0kV (Air discharge)

±4.0kV (Contact discharge)

#### 10.2.Block Diagram of Test Setup



Ground Reference Plane

#### 10.3.Test Procedure

- a. In the case of air discharge testing, the climatic conditions shall be within the following ranges:
- ambient temperature: 15°C to 35°C;
- relative humidity: 30% to 60%;
- atmospheric pressure: 86 kPa (860 mbar) to 106 kPa (1060 mbar)
- b. Test programs and software shall be chosen so as to exercise all normal modes of operation of the EUT. The use of special exercising software is encouraged, but permitted only where it can be shown that the EUT is being comprehensively exercised.
- c. In the case of contact discharges, the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.
- d. In the case of painted surface covering a conducting substrate, the following procedure shall be adopted: If the coating is not declared to be an insulating coating by the equipment manufacturer, then the pointed tip of the generator shall penetrate the coating so as to make contact with the conducting substrate. Coating declared as insulating by the manufacturer shall only be submitted to the air discharge. The contact discharge test shall not be applied to such surfaces.
- e. In the case of air discharges, the round discharge tip of the discharge electrode shall be approached as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator (discharge electrode) shall be removed from the EUT. The generator is then retriggered for a new single discharge. This procedure shall be repeated until the discharges are completed. In the case of an air discharge test, the discharge switch, which is used for contact discharge, shall be closed.
- f. The test voltage shall be increased from the minimum to the selected test severity level, in order to



determine any threshold of failure. The final test level should not exceed the product specification value in order to avoid damage to the equipment.

g. The test shall be performed with both air discharge and contact discharge. The test shall be performed with single discharges. On each pre-selected point at least 10 single discharges (in the most sensitive polarity) shall be applied. For the time interval between successive single discharges an initial value of 1 s is recommended. Longer intervals may be necessary to determine whether a system failure has occurred. h. Ensure that the applied charge on the EUT has been dis-charged before next ESD pulse.

#### 10.4. Test Results

#### **PASS**

Temperature : 23.3°C
Humidity : 45%
Atmospheric Pressure : 101kpa
Test Engineer : LHT

Test Date : 2021-12-15

Air Discharge:

Test Voltage	Location	Actual criterion	Required performance criterion	Result (Pass/Fail)	
±2; 4; 8 kV	SLOT	A	В	Pass	

Contact Discharge

Test Voltage	Location	Actual criterion	Required performance criterion	Result (Pass/Fail)
±2; 4kV	USB/SCREW/HD MI/LAN	Α	В	Pass

Indirect Discharge

Test Voltage	Location	Actual criterion	Required performance criterion	Result (Pass/Fail)	
±2; 4 kV	HCP	А	В	Pass	
±2; 4kV	VCP	A	В	Pass	



#### 11. CONTINUOUS RF ELECTROMAGNETIC FIELD DISTURBANCES

### 11.1.Test Specification

Test standard : EN 55035
Basic standard : IEC 61000-4-3

Performance criterion : A

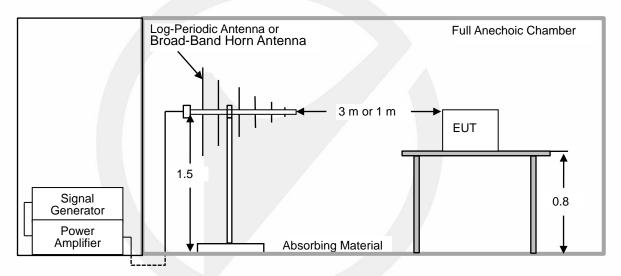
Frequency range & : ⊠80M-1000MHz 3V/m

Test level ⊠Spot frequency 3V/m

□ Additional spot frequency 3V/m

Modulation : AM, 80%, 1kHz sine-wave

## 11.2.Block Diagram of Test Setup



# 11.3.Test procedure

The procedure defined in this part requires the generation of electromagnetic fields within which the test sample is placed and its operation observed. To generate fields that are useful for simulation of actual (field) conditions may require significant antenna drive power and the resultant high field strength levels. To comply with local regulations and to prevent biological hazards to the testing personnel, it is recommended that these tests be carried out in a shielded enclosure or semi-anechoic chamber.

a. The antenna which is enabling the complete frequency range of 80-1000 MHz is placed 3m (or 1m) away from the equipment. The required field strength is determined by placing the field strength meter(s) on top of or directly alongside the equipment under test and monitoring the field strength meter via a remote field strength indicator outside the enclosure while adjusting the continuous-wave to the antenna. b. The test is performed with the antenna facing the front and back sides of the EUT with. Both vertical and horizontal polarizations from antenna are tested.



## 11.4.Test results

#### **PASS**

Temperature : 23.7°C Humidity : 52% Atmospheric Pressure : 101kpa Test Engineer : LHT

Test Date : 2021-12-15

## 

Freq. Range (MHz)	Field	Modulation	Polarity	Position (°)	Actual criterion	Required performance criterion	Result
80-1000	3V/m	AM, 80%	H/V	0, 90,180, 270	Α	Α	Pass

Spot frequency:

Freq (MHz)	Field	Modulation	Polarity	Position (°)	Actual criterion	Required performance criterion	Result
1800, 2600, 3500, 5000	3V/m	AM, 80%	H/V	0, 90,180, 270	Α	Α	Pass

☐ Additional spot frequency:

Freq (MHz)	Field	Modulation	Polarity	Position (°)	Actual criterion	Required performance criterion	Result
80, 120, 160, 230, 434, 460, 600, 863, 900	3V/m	AM, 80%	H/V	0, 90,180, 270	N/A	А	N/A



# 12. ELECTRICAL FAST TRANSIENTS/BURST

# 12.1.Test Specification

Test standard : EN 55035 Basic standard : IEC 61000-4-4

Performance criterion : B

Test level : ⊠1kV, AC mains power ports

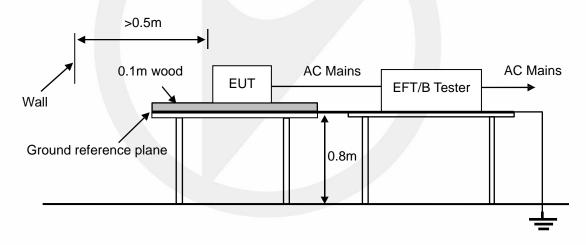
□ 0.5kV, DC network power ports □ 0.5kV, Analogue/digital data ports

Repetition frequency : ⊠5kHz, □100kHz(Only xDSL ports)

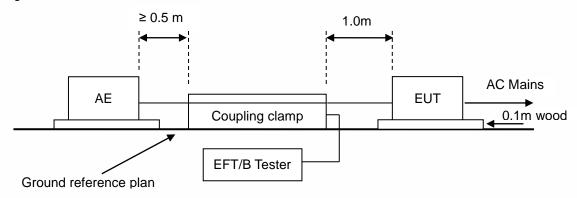
Tr/Th: : 5/50ns
Burst period : 300ms
Test time : : 120s

# 12.2.Block Diagram of Test Setup

#### AC Lines:



#### Signal lines:





#### 12.3.Test Procedure

The EUT is put on the table that is 0.1 meter high above the ground. This reference ground plane shall project beyond the EUT by at least 0.1m on all sides and the minimum distance between EUT and all other conductive structure, except the ground plane beneath the EUT, shall be more than 0.5m.

#### 12.4.Test Results

#### **PASS**

Temperature : 25.4°C Humidity : 50% Atmospheric Pressure : 101kpa

Test Engineer : LHT

Test Date : 2021-12-15

Injection Line	Voltage (kV)	Injected Method	Actual criterion	Required performance criterion	Result (Pass/Fail)
AC mains power ports	± 1	<ul><li>☐ CDN</li><li>☐ Direct injection</li><li>☐ Capacitive coupling clamp</li></ul>	A	В	Pass
☐ DC network power ports	± 0.5	<ul><li>☐ CDN</li><li>☐ Direct injection</li><li>☐ Capacitive coupling clamp</li></ul>	N/A	N/A	N/A
Analogue/digital data ports (Wired network port)	± 0.5	<ul><li>☐ CDN</li><li>☐ Direct injection</li><li>☐ Capacitive coupling clamp</li></ul>	А	В	N/A
Analogue/digital data ports (Broadcast receiver tuner port)	± 0.5	☐ CDN ☐ Direct injection ☐ Capacitive coupling clamp	N/A	N/A	N/A
Analogue/digital data ports ()	± 0.5	<ul><li>☐ CDN</li><li>☐ Direct injection</li><li>☐ Capacitive coupling clamp</li></ul>	N/A	N/A	N/A



### 13. SURGES

### 13.1.Test Specification

Test standard : EN 55035 Basic standard : IEC 61000-4-5

Test level : ⊠1kV, Line to Line, AC mains power ports, Criterion B

≥2kV, Line to Earth, AC mains power ports, Criterion B

□0.5kV, Line to Reference ground, DC network power ports, Criterion B

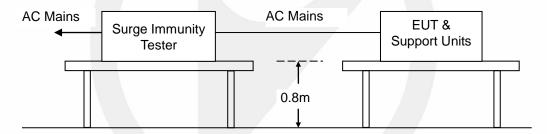
☐ 1.0kV, Lines to Ground, Unshielded symmetrical, Criterion C☐ 4.0kV, Lines to Ground, Unshielded symmetrical, Criterion C☐ 0.5kV, Shield to ground, Coaxial or shielded port, Criterion B

Number of surges : 5 (for each combination of parameters)

Repetition rate : 1 minute / time
Polarity: : Positive / Negative

Phase angle: 90°, 270° (Only AC mains power ports)

### 13.2.Block Diagram of Test Setup



#### 13.3.Test Procedure

This test simulates a lightning event by inducing transients onto the AC/DC power supply lines in common mode (Line to Ground) and differential mode (Line to Line). Each device was tested in a total of two surge configurations: Line to Ground (L-G): Combination Wave, Line to Protective Earth with 9uF and 10Ohm and Neutral to Protective Earth with 9uF and 10Ohm, common mode, generator earthed.

Line to Line (L-L): Combination Wave,

Line to Neutral with 18uF, differential mode, generator floated.

2 ohm: the source impedance of the low-voltage power supply network.

12 ohm: the source impedance of the low-voltage power supply network and ground.

- a. If not otherwise specified the surges have to be applied synchronized to the voltage phase at the zero-crossing and the peak value of the a.c. voltage wave (positive and negative).
- b. The surges have to be applied line to line and line to earth. When testing line to earth, the test voltage has to be applied successively between each of the lines and earth, if there is no other specification.
- c. The test procedure shall also consider the non-linear current-voltage characteristics of the equipment under test. Therefore the test voltage has to be increased by steps up to the test level specified in the product standard or test plan. All lower levels including the selected test level shall be satisfied.
- d. For testing the secondary protection, the output voltage of the generator shall be increased up to the worst-case voltage breakdown level (let-through level) of the primary protection.
- e. Testing shall be performed according to a Test Plan, which shall be included in the test report.



f. To find all critical points of the duty cycle of the equipment, a sufficient number of positive and negative test pulses shall be applied.

#### 13.4. Test results

#### **PASS**

Temperature 25.4°C Humidity 50% Atmospheric Pressure 101kpa Test Engineer LHT

Test Date 2021-12-15

AC mains power ports:

Coupling Line	Voltage (kV)	Waveform (µs)	Polarity	Actual criterion	Required performance criterion	Result (Pass/Fail)
∠ Line to line	0.5, 1	1.2/50 (8/20)	Pos./ Neg.	Α	В	Pass
∠ Line to earth	0.5, 1, 2	1.2/50 (8/20)	Pos./ Neg.	A	В	Pass

□ DC network power ports: Required Voltage Waveform Actual Result **Polarity** Coupling Line performance (kV) criterion (Pass/Fail) (µs) criterion

Line to Reference 0.5 1.2/50 (8/20) Pos./ Neg. N/A В N/A ground

Analogue/digital data ports:

Port type	Coupling Line	Voltage (kV)	Waveform (µs)	Polarity	Actual criterion	Required performance criterion	Result (Pass/Fail)
Unshielded symmetrical (Wired network port)	Lines to ground	0.5, 1	10/700 (5/320)	Pos./ Neg.	А	С	N/A
Unshielded symmetrical ()	Lines to ground	0.5, 1	10/700 (5/320)	Pos./ Neg.	N/A	С	N/A
Unshielded symmetrical	Lines to ground	0.5, 1, 2, 4	10/700 (5/320)	Pos./ Neg.	N/A	С	N/A
Coaxial or shielded (Broadcast receiver tuner port)	Shield to ground	0.5	1.2/50 (8/20)	Pos./ Neg.	N/A	С	N/A
Coaxial or shielded ()	Shield to ground	0.5	1.2/50 (8/20)	Pos./ Neg.	N/A	С	N/A



#### 14. CONTINUOUS INDUCED RF DISTURBANCES

#### 14.1.Test Specification

Test standard : EN 55035
Basic standard : IEC 61000-4-6

Performance criterion : A

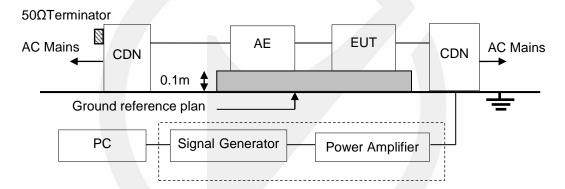
Frequency range & : 0.15M to 10MHz, 3V Test level : 0.15M to 30MHz, 3V to 1V

30M to 80MHz, 1V

Modulation : AM 80%, 1kHz sine-wave

Frequency Step : 1% of fundamental

#### 14.2.Block Diagram of Test Setup



#### 14.3.Test Procedure

- a. The EUT shall be operated within its intended climatic conditions. The temperature and relative humidity should be recorded.
- b. The EUT is placed on a 0.1m high test table, and a well grounded cable is connected to metallic plane above the test table.
- c. All cables/wires must be laid out on test plate (3cm in thickness),and the EUT is set up on test plate (10 cm in thickness) as shown in test setup photo, and the cables/wires must not be in mid-air, they should be touching the surface of test plate. Ensure that the EUT is properly connected to the accessory equipment.
- d. The test shall be performed with the test generator connected to each of the coupling and decoupling devices in turn while the other non-excited RF-input ports of the coupling devices are terminated by a 50 ohm load resistor.
- e. The frequency range is swept from 150 kHz to 80 MHz, using the signal levels established during the setting process, and with the disturbance signal 80% amplitude modulated with a 1 kHz sine wave, pausing to adjust the RF-signal level or to switch coupling devices as necessary. The rate of sweep shall no exceed 1.5 x 10-3 decades/s. Where the frequency is swept incrementally, the step size shall no exceed 1% of the start and thereafter 1% of the preceding frequency value.
- f. The dwell time at each frequency shall not be less than the time necessary for the EUT to be exercised, and able to respond. Sensitive frequencies e.g. clock frequency (ies) and harmonics or frequencies of dominant interest shall be analyzed separately.
- g. Attempts should be made to fully exercise the EUT during testing, and to fully interrogate all exercise modes selected for susceptibility
- h. Testing shall be performed according to a Test Plan, which shall be included in the test report.



## 14.4.Test results

#### **PASS**

Temperature : 25.4°C
Humidity : 50%
Atmospheric Pressure : 101kpa
Test Engineer : LHT

Test Date : 2021-12-15

Range (MHz)	Levers (V)	Injection port	Coupling type	Actual criterion	Required performance criterion	Result (Pass/Fail)	
0.15-10	3		⊠CDN	А	А		
10-30	3-1	⊠AC mains power ports	☐EM Clamp ☐Current Clamp			Pass	
30-80	1		Direct injection				
0.15-10	3		□CDN	N/A	N/A	N/A	
10-30	3-1	DC network power ports	☐EM Clamp ☐Current Clamp				
30-80	1		Direct injection				
0.15-10	3	☐Analogue/digital data	□CDN □EM Clamp □Current Clamp □Direct injection	A	А		
10-30	3-1	ports				N/A	
30-80	1	(Wired network port)					
0.15-10	3	☐Analogue/digital data	□CDN □EM Clamp □Current Clamp	N/A	N/A		
10-30	3-1	ports (Broadcast receiver tuner				N/A	
30-80	1	port)	Direct injection				
0.15-10	3	☐Analogue/digital data	□CDN	N/A	N/A		
10-30	3-1	ports	☐EM Clamp ☐Current Clamp			N/A	
30-80	1	()	Direct injection				



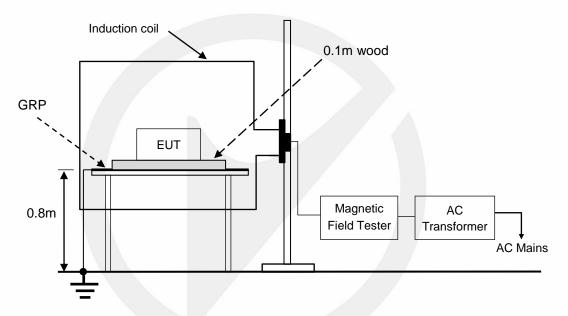
## 15. POWER FREQUENCY MAGNETIC FIELD

## 15.1.Test Specification

Test Standard : EN 55035 Basic Standard : IEC 61000-4-8

Performance criterion : A
Test level : 1A/m

#### 15.2.Block Diagram of Test Setup



GRP: Ground reference plane EUT: Equipment under test

#### 15.3.Test Procedure

The EUT is placed in the middle of a induction coil (1\*1m), under which is a 1\*1\*0.1m (high) table, this small table is also placed on a larger table, 0.8 m above the ground. Both horizontal and vertical polarization of the induction coil is set on test, so that each side of the EUT is affected by the magnetic field. Also can reach the same aim by change the position of the EUT.



#### 15.4.Test Results

#### **PASS**

Temperature : 25.4°C
Humidity : 50%
Atmospheric Pressure : 101kpa
Test Engineer : LHT

Test Date : 2021-12-15

Test Level (A/m)	Frequency	Testing Coil Duration Orientation		Actual criterion	Required performance criterion	Result (Pass/Fail)
1	1		x-axis y-axis z-axis	А	А	Pass



#### 16. VOLTAGE DIPS AND INTERRUPTIONS

## 16.1.Test Specification

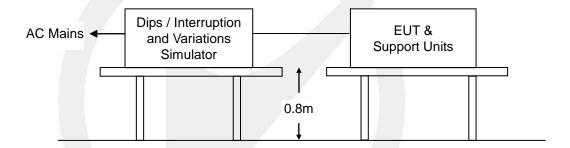
Test standard : EN 55035

Basic standard : IEC 61000-4-11

Test level : 0%, 0.5 period, Criterion B

∑70%, 25 periods for 50Hz, Criterion C
∑70%, 30 periods for 60Hz, Criterion C
∑0%, 250 periods for 50Hz, Criterion C
∑0%, 300 periods for 60Hz, Criterion C

### 16.2.Block Diagram of Test Setup



#### 16.3. Test Procedure

- a. Where the equipment has a rated voltage the following shall apply If the voltage range does not exceed 20% of the lower voltage specified for the rated voltage range, a single voltage within that range may be specified as a basis for test level specification.
- In all other cases, the test procedure shall be applied for both the lowest and highest voltages declared in the voltage range.
- b. Test Conditions
- Select operated voltage and frequency of EUT Test of interval : 10 sec.
- Level and duration : Sequence of 3 dips/interrupts.
- Voltage rise (and fall) time: 1.5 μs.



#### 16.4. Test results

#### **PASS**

Temperature : 25.4°C
Humidity : 50%
Atmospheric Pressure : 101kpa
Test Engineer : LHT

Test Date : 2021-12-15

	Test Level (% UT)	Phase angle (°)	Input Voltage (V)	Freq (Hz)	Duration (periods)	Actual criterion	Required performance criterion	Result (Pass /Fail)
⊠Voltage dips	0%	0°, 180°	AC 230V	50	0.5	А	В	Pass
⊠Voltage dips	0%	0°, 180°	AC 120V	60	0.5	А	В	Pass
⊠Voltage dips	70%	0°, 180°	AC 230V	50	25	А	С	Pass
⊠Voltage dips	70%	0°, 180°	AC 120V	60	30	А	С	Pass
⊠Voltage interruptions	0%	0°, 180°	AC 230V	50	250	В	С	Pass
⊠Voltage interruptions	0%	0°, 180°	AC 120V	60	300	В	С	Pass

Note: 1. Dips to 0%, Duration 250P, EUT stopped operation, but can be automatically restored.

2. Dips to 0%, Duration 300P, EUT stopped operation, but can be automatically restored.

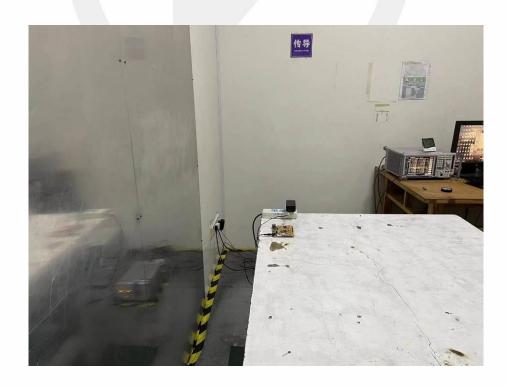
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# 17. PHOTOGRAPHS

## 17.1. Photos of Conducted Emissions from the AC Mains Power Ports

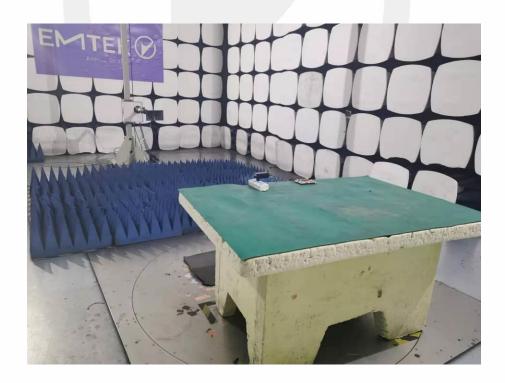






## 17.2. Photos of Radiation Emission Measurement







## 17.3. Photo of Harmonic / Flicker Measurement



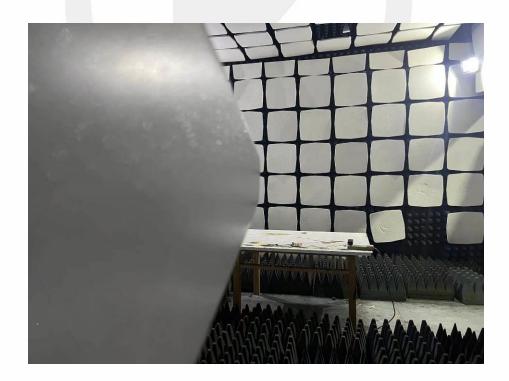
# 17.4. Photo of Electrostatic Discharges





# 17.5. Photo of Continuous RF Electromagnetic Field Disturbances

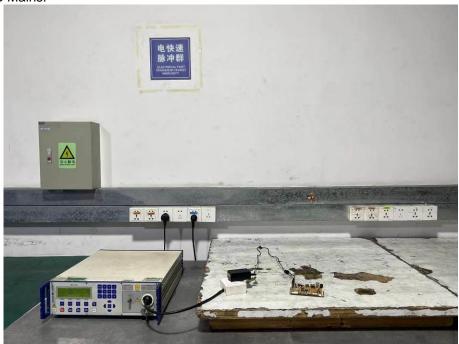






#### 17.6.Photos of Electrical Fast Transients/Burst

#### AC Mains:



# 17.7.Photos of Surges

#### AC Mains:





## 17.8. Photos of Continuous Induced RF Disturbances

AC Mains:



# 17.9. Photo of Power Frequency Magnetic Field





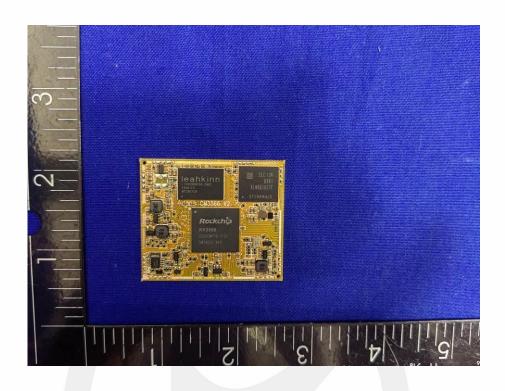
# 17.10.Photo of Voltage Dips and Interruptions

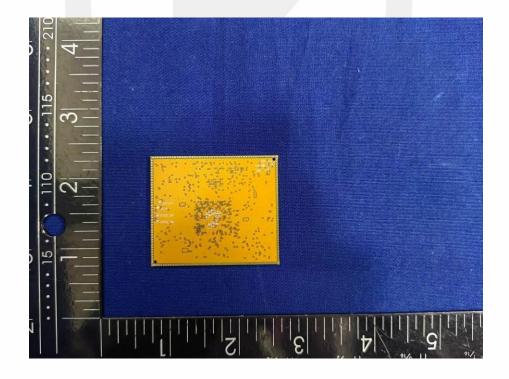




APPENDIX (PHOTOS OF EUT)







\*\*\* End of Report \*\*\*